

Home | Login | Logout | Access Information | Alerts |

Welcome United States Patent and Trademark Office

Search Results

BROWSE

SEARCH

IEEE XPLORE GUIDE

Your sear	ch matched 9 of 11	54623 doc	mode) <in>metadata)" ∭e-ਸਬ uments. l, 25 to a page, sorted by Relevance in Descending order.</in>	ıii
	sion History		, = ,	
» <u>View Ses</u> » <u>New Sear</u>				
	.		fy Search Ilifier 'and' switching mode) <in>metadata)</in>	
» Key		((amp	lifier 'and' switching mode) <in>metadata)</in>	
IEEE JNL	IEEE Journal or Magazine		heck to search only within this results set	
IEE JNL	IEE Journal or Magazine	Displ	ay Format: Citation & Abstract Citation & Abstract	
IEEE CNF	IEEE Conference Proceeding	Select	Article Information	
IEEE CNF	IEE Conference Proceeding IEEE Standard		 Coupled magnetic amplifiers in forward converter topologies Barry, N.; Daly, B.; Power Electronics, IEEE Transactions on Volume 14, Issue 1, Jan. 1999 Page(s):168 - 176 	٠
			AbstractPlus References Full Text: PDF(220 KB) IEEE JNL	
			/ Mondow Tab Telescope Fair Fox. F. (220 Fe) Telescope Fair Fox. (220 Fe) Telescope (220 Fe) (220 Fe)	
			 Design and performance of tunnel collector HBTs for microwave power amplified Welty, R.J.; Mochizuki, K.; Lutz, C.R.; Welser, R.E.; Asbeck, P.M.; Electron Devices, IEEE Transactions on Volume 50, Issue 4, April 2003 Page(s):894 - 900 	∍r
			AbstractPlus References Full Text: PDF(414 KB) IEEE JNL	
			3. Class-D amplification combined with switched-mode power conditioning-the ro battery life Grant, D.A.; Darroman, Y.; Burrow, S.; Consumer Electronics, IEEE Transactions on Volume 48, Issue 3, Aug. 2002 Page(s):677 - 683 AbstractPlus Full Text: PDF(946 KB) IEEE JNL	u [.]
			4. Time-domain optical sampling of switched-mode microwave amplifiers and mul Weiss, M.D.; Crites, M.H.; Bryerton, E.W.; Whitaker, J.F.; Popovic, Z.; Microwave Theory and Techniques, IEEE Transactions on Volume 47, Issue 12, Dec. 1999 Page(s):2599 - 2604	iti
			AbstractPlus References Full Text: PDF(220 KB) IEEE JNL	
·			5. High dynamic class-D power amplifier Himmelstoss, F.A.; Edelmoser, K.H.; Consumer Electronics, IEEE Transactions on Volume 44, Issue 4, Nov. 1998 Page(s):1329 - 1333	
			AbstractPlus Full Text: PDF(368 KB) IEEE JNL	
			6. Effect of switch duty ratio on the performance of class E amplifiers and frequent Albulet, M.; Zulinski, R.E.; Circuits and Systems I: Fundamental Theory and Applications, IEEE Transactions on and Systems I: Regular Papers, IEEE Transactions on] Volume 45, Issue 4, April 1998 Page(s):325 - 335	

AbstractPlus | References | Full Text: PDF(468 KB) | IEEE JNL

 8. Basic considerations and topologies of switched-mode assisted linear power ar Ertl, H.; Kolar, J.W.; Zach, F.C.; Industrial Electronics, IEEE Transactions on Volume 44, Issue 1, Feb. 1997 Page(s):116 - 123 AbstractPlus References Full Text: PDF(168 KB). IEEE JNL 9. Feedforward pulse width modulators for switching power converters Arbetter, B.; Maksimovic, D.; Power Electronics, IEEE Transactions on Volume 12, Issue 2, March 1997 Page(s):361 - 368 AbstractPlus References Full Text: PDF(264 KB) IEEE JNL 	7.	Linear high-efficiency microwave power amplifiers using bandpass delta-sigma in Jayaraman, A.; Chen, P.F.; Hanington, G.; Larson, L.; Asbeck, P.; Microwave and Guided Wave Letters, IEEE [see also IEEE Microwave and Wireless C Letters] Volume 8, Issue 3, March 1998 Page(s):121 - 123 AbstractPlus References Full Text: PDF(72 KB) IEEE JNL
9. Feedforward pulse width modulators for switching power converters Arbetter, B.; Maksimovic, D.; Power Electronics, IEEE Transactions on Volume 12, Issue 2, March 1997 Page(s):361 - 368	8.	Ertl, H.; Kolar, J.W.; Zach, F.C.; Industrial Electronics, IEEE Transactions on
Arbetter, B.; Maksimovic, D.; Power Electronics, IEEE Transactions on Volume 12, Issue 2, March 1997 Page(s):361 - 368		AbstractPlus References Full Text: PDF(168 KB) IEEE JNL
AbstractPlus References Full Text: PDF(264 KB) IEEE JNL	9.	Arbetter, B.; Maksimovic, D.; Power Electronics, IEEE Transactions on
		AbstractPlus References Full Text: PDF(264 KB) IEEE JNL

View Selected Items

Help Contact Us Privacy &: #Inspec © Copyright 2005 IEEE -

